

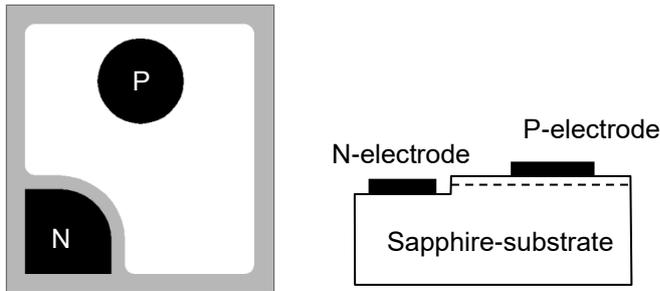
> Mechanical Specification:

(1) Dimension

- Chip size: 11 mil x 12 mil ($280 \pm 25 \mu\text{m} \times 305 \pm 25 \mu\text{m}$)
- Thickness: 4.3 mil ($110 \pm 10 \mu\text{m}$)
- P bonding pad: 3.5 mil ($90 \pm 10 \mu\text{m}$)
- N bonding pad: 3.5 mil ($90 \pm 10 \mu\text{m}$)

(2) Metallization

- Topside P electrode: Au alloy
- Topside N electrode: Au alloy



Features:

- High luminous intensity
- Long operation life

Applications:

- Automotive

> Electro-optical Characteristics at 25°C: ⁽¹⁾

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit	
Forward Voltage	Vf1	If = 10μA	1.8	-	-	V	
	Vf2	If = 20mA	2.8	-	3.8	V	
Reverse Current	Ir	Vr = 5V	-	-	1.0	μA	
Dominant Wavelength ⁽²⁾	λd	If = 20mA	515	-	535	nm	
Spectra Half-width	Δλ	If = 20mA	-	35	-	nm	
Luminous intensity ⁽³⁾	Iv	X5	If = 20mA	167	-	200	mcd
		X6		200	-	240	
		X7		240	-	300	

Note:

(1) ESD protection during chip handling is recommended.

(2) Basically, the wavelength span is 20nm; however, customers' special requirements are also welcome.

(3) Luminous intensity is measured by EPISTAR's equipment on bare chips.

> Absolute Maximum Ratings:

Parameter	Symbol	Condition	Rating	Unit
Forward DC Current	If	Ta = 25°C	≤ 30	mA
Reverse Voltage	Vr	Ta = 25°C	≤ 5	V
Junction Temperature	Tj	-	≤ 115	°C
ESD withstand voltage(HBM) ⁽²⁾	VESD	-	Up to 2	KV
Storage Temperature	Tstg	Chip	-40 ~ +85	°C
		Chip-on-tape/storage	5 ~ 35	°C
		Chip-on-tape/transportation	-20 ~ +65	°C
Temperature during Packaging	-	-	280(<10sec)	°C

Note: (1) Maximum ratings are package dependent. The above maximum ratings were determined using a Printed Circuit Board (PCB) without an encapsulant. Stresses in excess of the absolute maximum ratings such as forward current and junction temperature may cause damage to the LED.

(2) According to ANSI/ESDA/JEDEC JS-001

> Characteristic Curves:

Fig.1-Relative Luminous Intensity vs. Forward Current

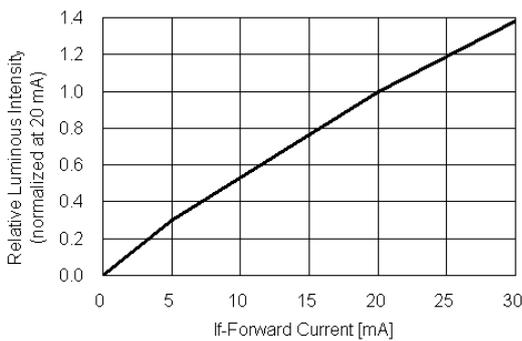


Fig.3-Relative Intensity (@20mA) vs. Ambient Temperature

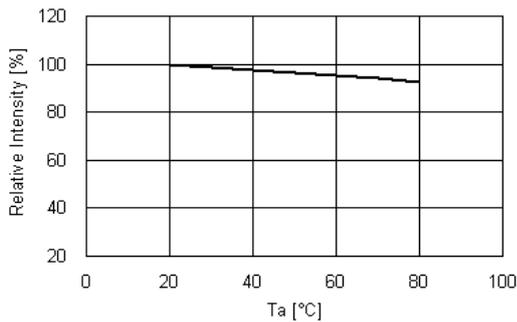


Fig.5-Dominant Wavelength(@20mA) vs. Ambient Temperature

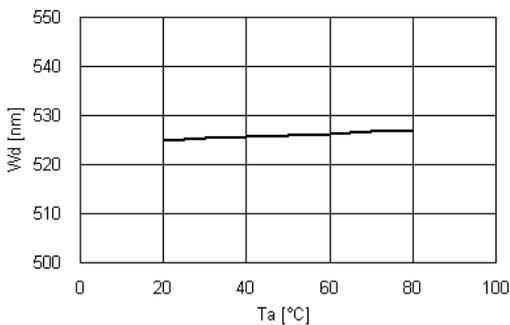


Fig.2- Forward Current vs. Forward Voltage

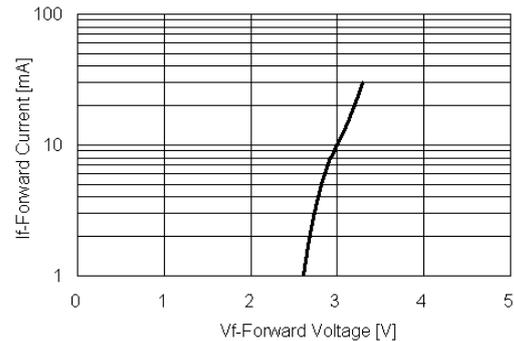


Fig.4-Forward Voltage (@20mA) vs. Ambient Temperature

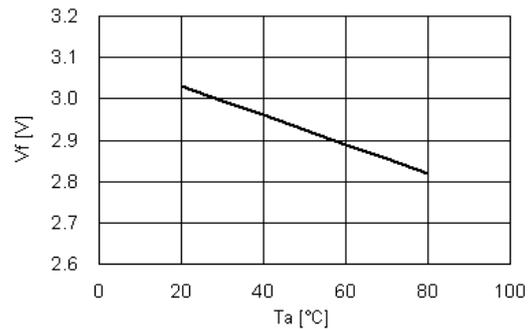
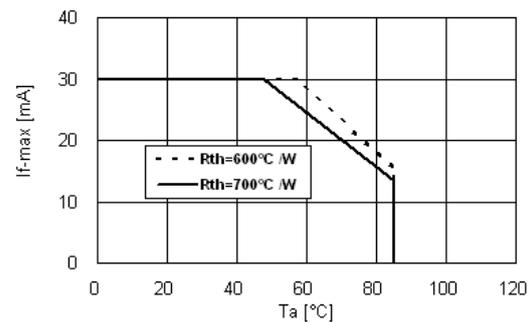


Fig.6 Maximum Driving Forward DC Current vs. Ambient Temperature (Derating based on Tj max. = 115°C)



> Qualification:

- ¹⁾ EPISTAR's LED chips and epi-wafers are designed and manufactured according to the quality management system that complies to the IATF 16949:2016 requirements (IATF No: 0325277/ Certificate Registration No: 20000910 IATF16).
- ²⁾ The chip qualification test plan is based on the guidelines of AEC-Q101-REV-D, Failure Mechanism Based Stress Test Qualification for Discrete Semiconductors in Automotive Applications.

> Revision:

Version	Page	Subjects	Date of Modification
A	3	Initial Release	October 22